

RADFET Ground Calibration and BioRADFET Experiment

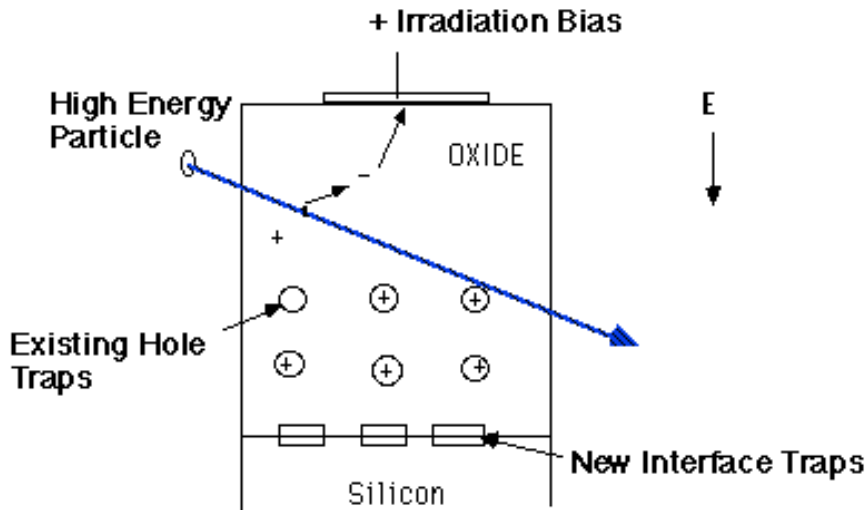
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Aleksandar Jaksic, Vladimir Ogourtsov
Tyndall National Institute, Cork, Ireland

Outline:

- What is RADFET and how does it work?
- RADFET characterisation
- BioRADFET project
- Recent success story

RADFET operating principle:

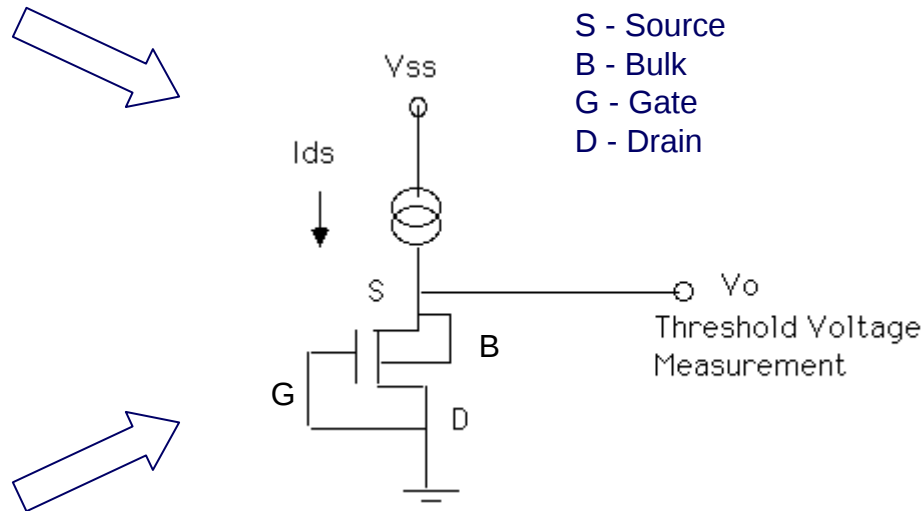


- Radiation creates electron-hole pairs
- Initial recombination of electrons and holes happens
- Non-recombined electrons leave the oxide;
holes are trapped in the vicinity of the oxide/silicon interface
- RADFET threshold voltage (V_T) changes ($\Delta V_T \sim \text{Dose}$)

RADFET biasing configurations:

- Irradiation (sense mode): zero current; (B, S and D grounded); G can be:
 - Grounded ($V_{IRR}=V_{GS}=0V$)
 - Biased (typically $V_{IRR}=V_{GS}>0$)

Read-out mode: specified current ($I_{ds}=I_O$) applied to S=B; G=D grounded



- Irradiation (sense mode) and Read-out mode are the same

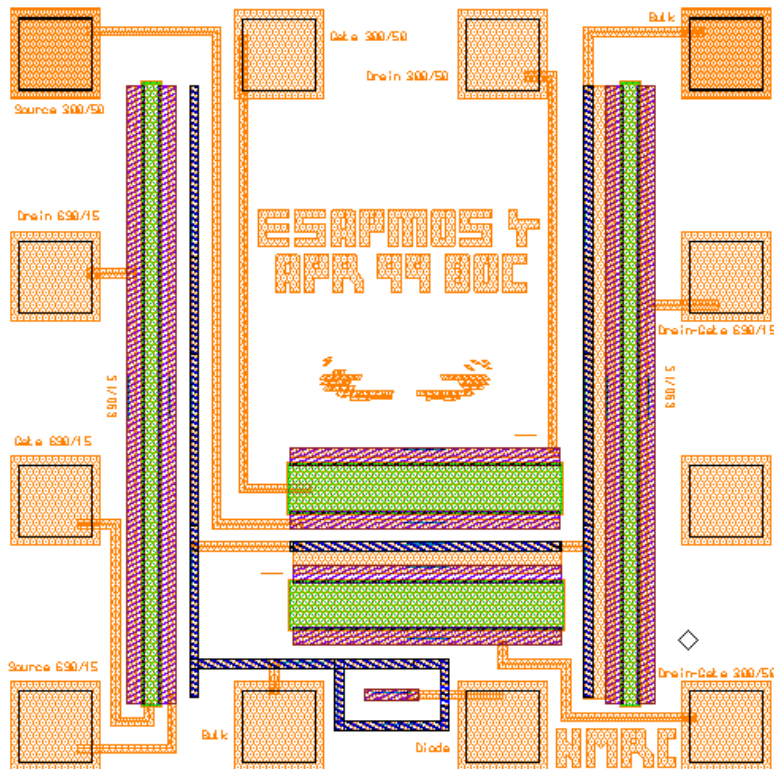
RADFET advantages over other dosimeters:

- Immediate read-out without destroying the data
- Extremely small sensor chip
- Very low or zero power consumption
- Technology suitable for connection to a microprocessor
- Comparatively low cost

Applications:

- Nuclear industry and research
- Space dosimetry
- Radiotherapy
- Personal dosimetry [?]

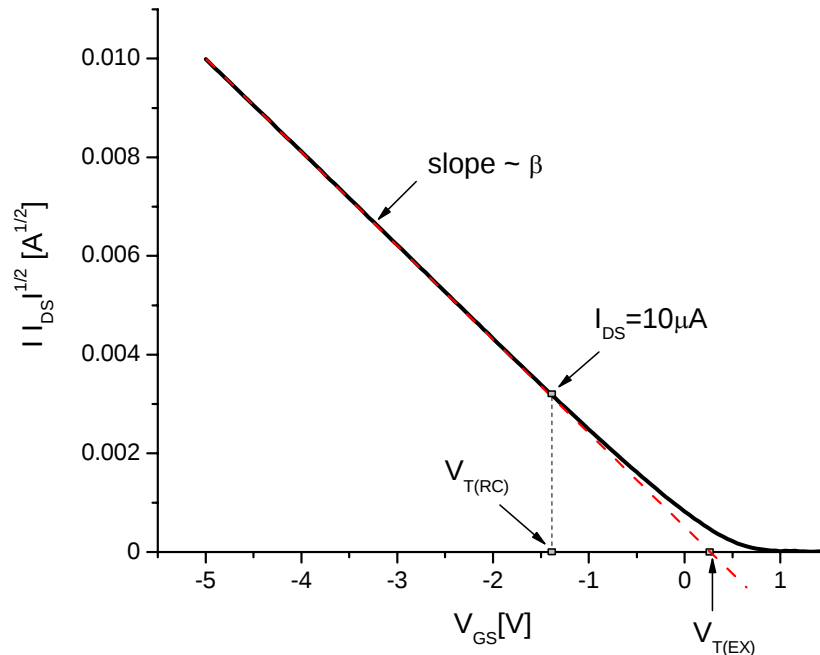
ESAPMOS4 RADFET chip:



- Chip size: 1mm x 1mm
- Contains four RADFETs:
 - two 300/50 devices
 - two 690/15 devices
- Chip types (gate oxide):
 - 100 nm
 - 400 nm
 - 400 nm Implanted (IMPL)
 - 1 μm
 - 1 μm Implanted (IMPL)

Pre-irradiation characterisation RADFETs:

Device type	$V_{T(RC)} @ 10\mu A$ [V]	$V_{T(EX)}$ [V]	β [$\times 10^{-6} A/V^2$]	SS [mV/decade]
300/50 standard	-1.524 ± 0.124	0.193 ± 0.111	6.947 ± 0.127	263 ± 8
300/50 passivated	-1.630 ± 0.097	0.092 ± 0.105	6.986 ± 0.167	254 ± 9
690/15 standard	-0.201 ± 0.084	0.293 ± 0.072	75.370 ± 1.288	228 ± 5
690/15 passivated	-0.330 ± 0.067	0.148 ± 0.064	78.130 ± 1.956	225 ± 6

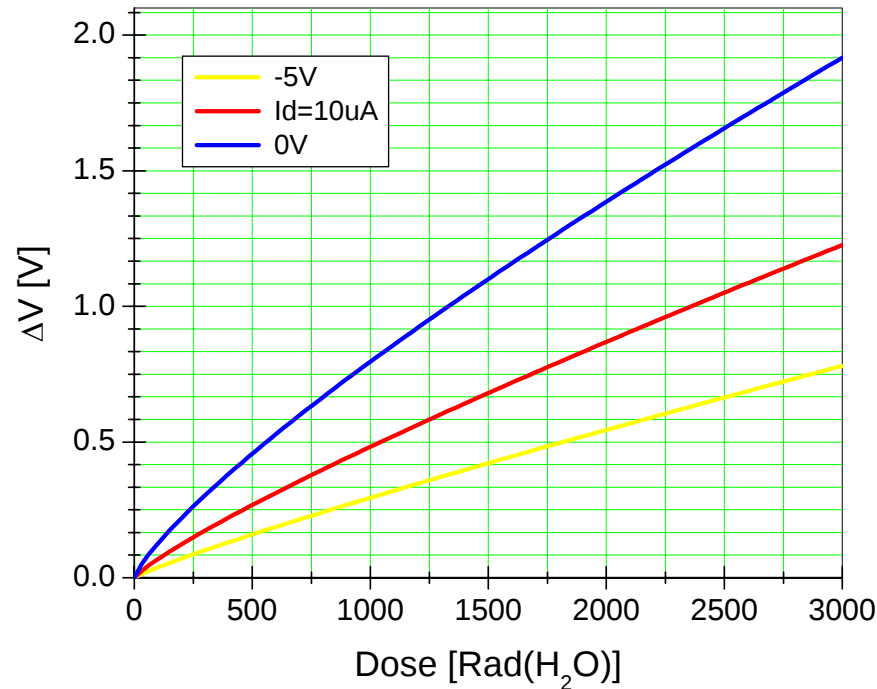


- No effect of passivation on pre-irradiation characteristics
- Changes in $V_{T(RC)}$ and $V_{T(EX)}$ are the same
- Changes in $V_{T(RC)}$ for different read-out currents are the same

Passivation effect on radiation response:

- Sensitivity after 200cGy Co-60 dose:
 - Unpassivated RADFETs: $\sim 0.55\text{mV/rad}$
 - Passivated RADFETs (200nm Si_3N_4): $\sim 0.75\text{mV/rad}$
 - Passivated RADFETs , passivation stripped: $\sim 0.55\text{mV/rad}$
 - Passivated RADFETs, passivation stripped + CVD oxide: $\sim 0.70\text{mV/rad}$
- Main culprits: hydrogen and/or stress

Co-60 calibration curves (400nm IMPL):

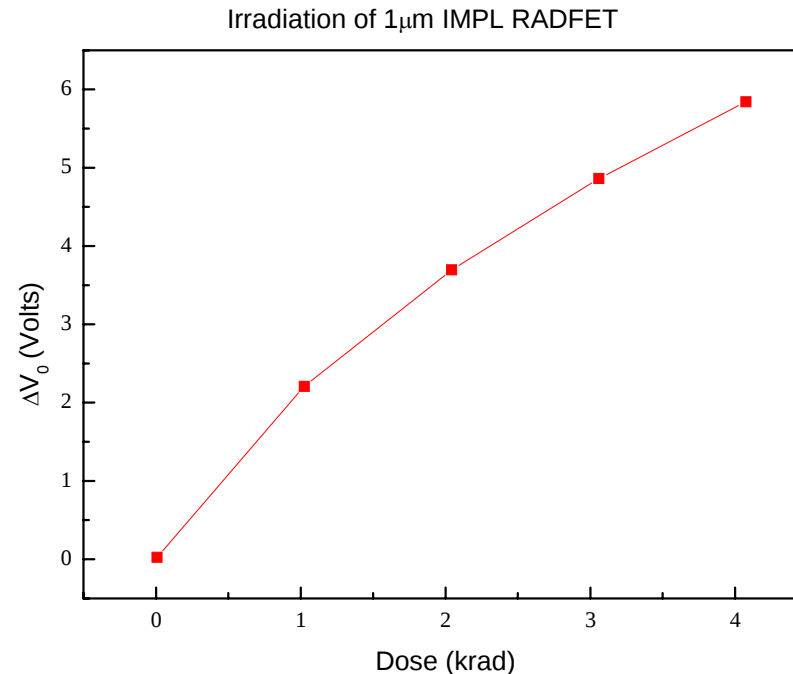


Calibration coefficients

The curve equation is of the form: $\Delta V = a \times \text{Dose}^b$; ΔV [Volts], Dose[Rad(H_2O)].

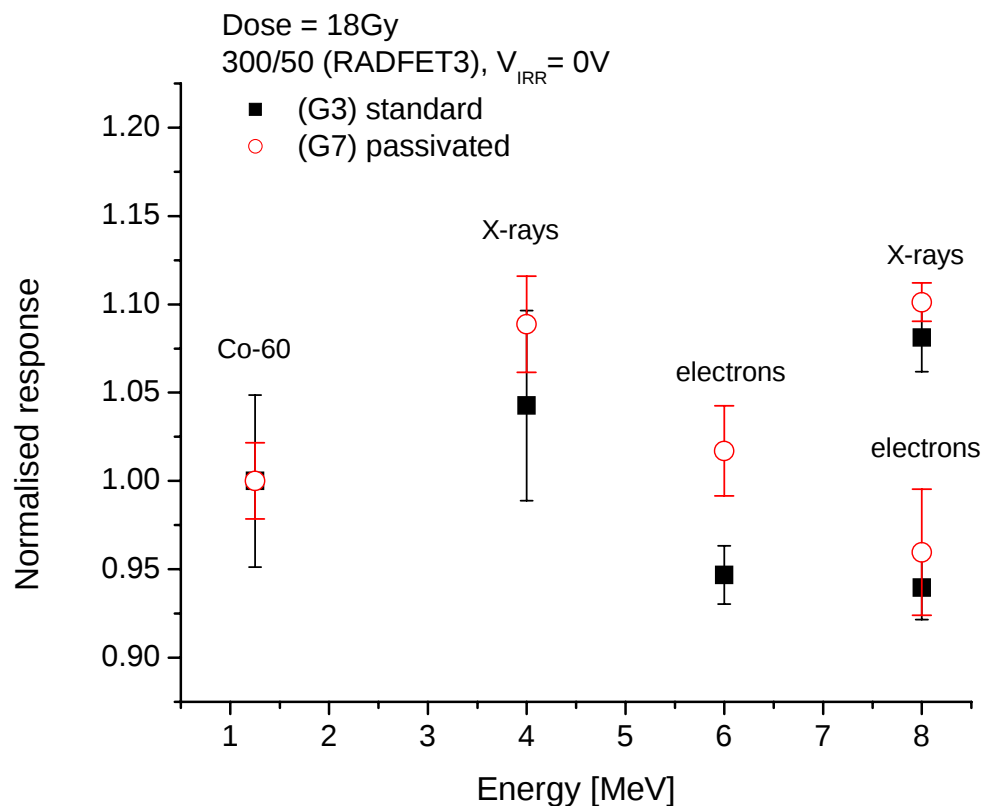
Bias	a	b	R-square	SSE
-5V	0.000643	0.8871	0.9999	0.00042
Cont $I_d=10\mu A$	0.001365	0.8494	0.9994	0.00475
0V	0.003166	0.8001	0.9976	0.04626

Co-60 irradiation (1 μ m IMPL):

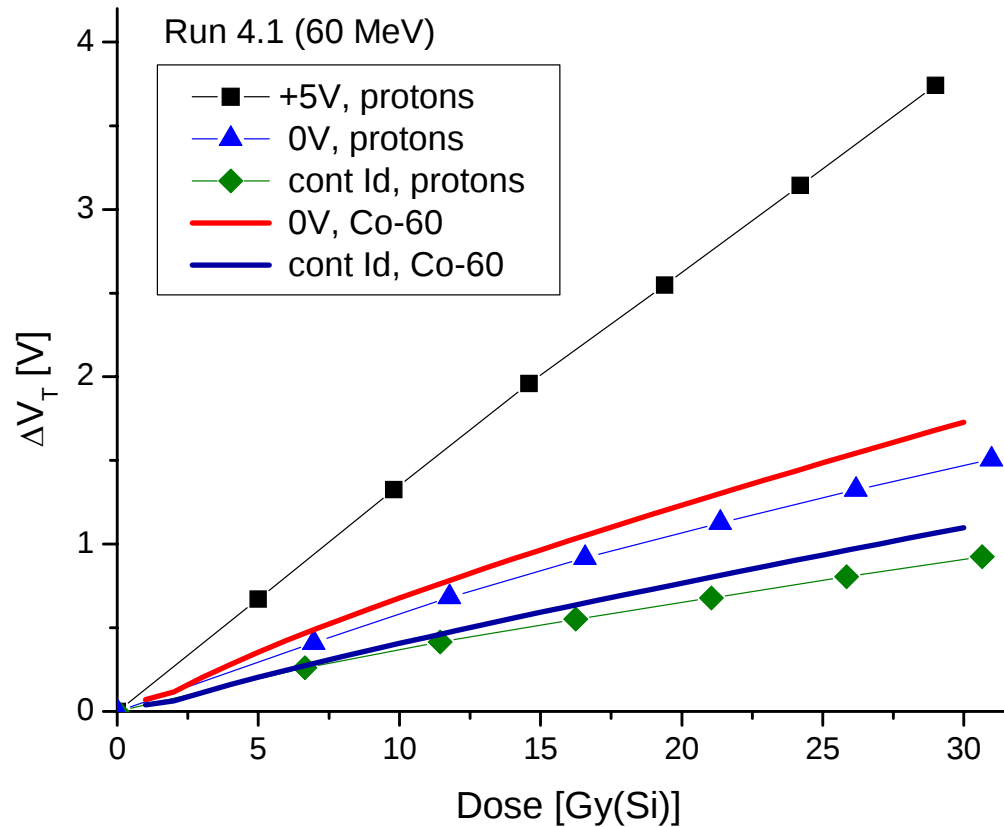


- Preliminary radiation data (courtesy Avner Haran, Soreq NRC)
- Most sensitive non-stacked RADFET up to date
- Initial threshold voltages very uniform, fading low

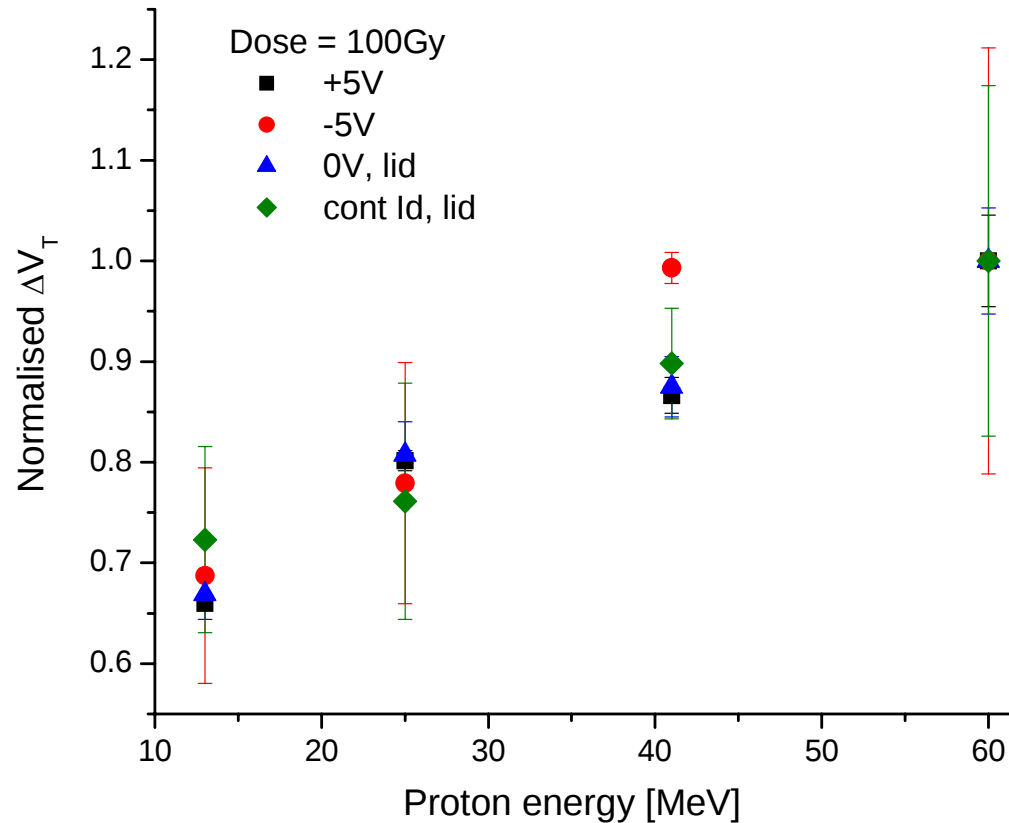
Electron irradiation (zero V_{IRR} , normalised):



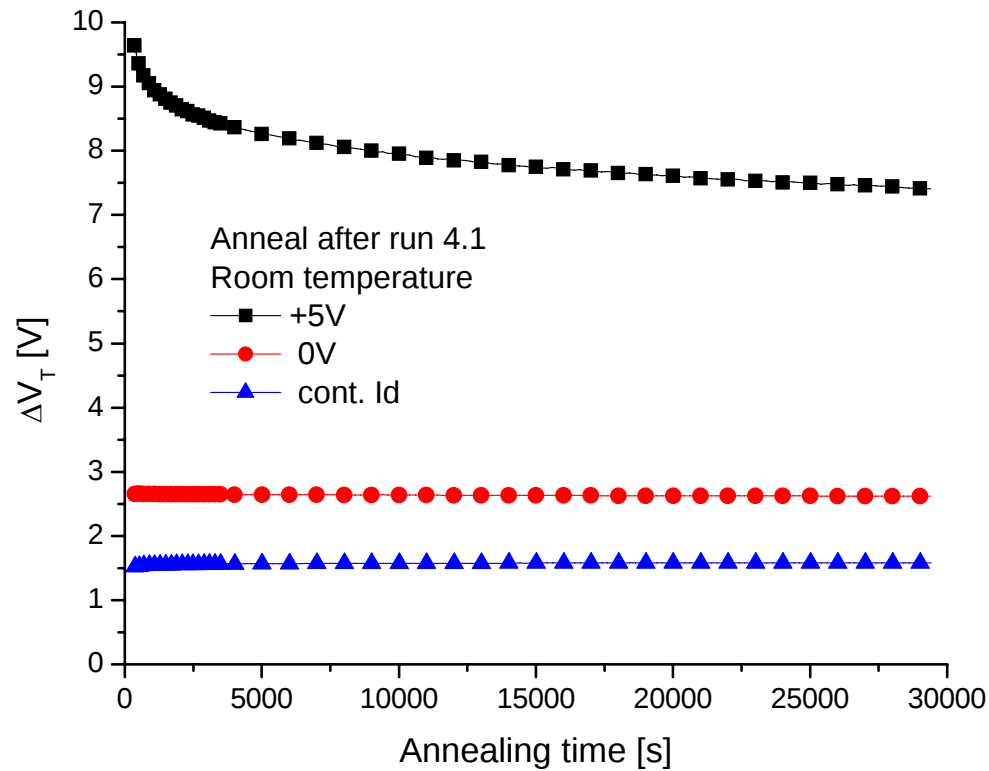
Proton irradiation:



Proton energy dependence (normalised):



Post-irradiation annealing (fading):



- Proton data shown, similar data for other types of radiation

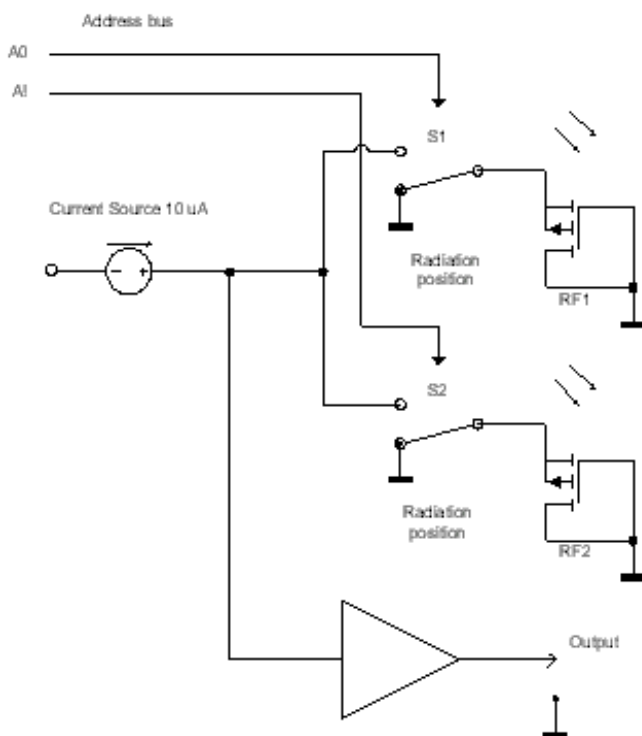
Irradiation response summary:

- Flat energy response to photons and electrons (1-8MeV)
- Energy dependent response to protons (10-60 MeV)
- Preferred biasing configurations:
 - Zero gate bias ($V_{IRR}=0V$)
 - ✓ Good sensitivity
 - ✓ Low fading
 - × Need to switch between irradiation and read-out mode
 - Continuous I_o
 - × Somewhat decreased sensitivity
 - ✓ Low fading
 - ✓ No need for switching between irradiation and read-out mode

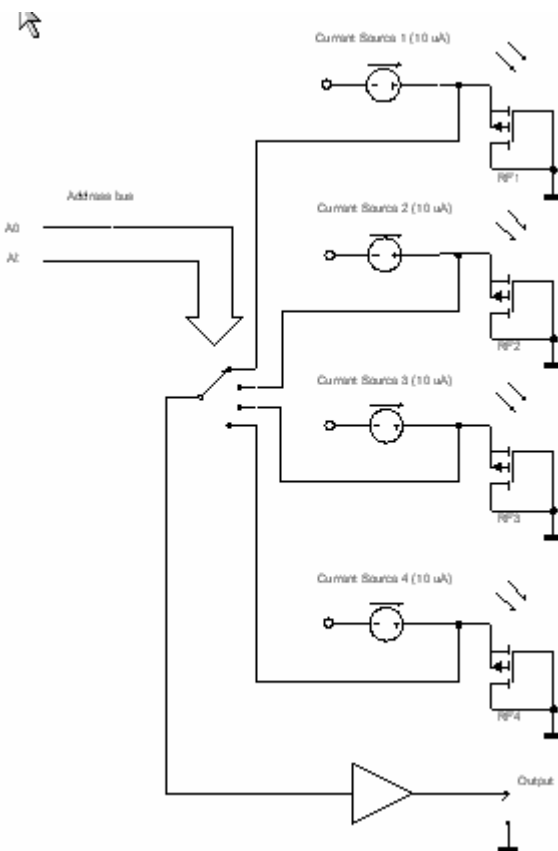
BioRADFET project:

- Part of the Biopan-5 experiment on Photon-M2
- Lunch scheduled for Wednesday next week
- RADFET reader board (BioRADFET)
 - DC power supply: 12V (continuous)
 - Maximum current: 0.5mA
 - Two TTL control lines to control multiplexer/switches

BioRADFET configurations considered:

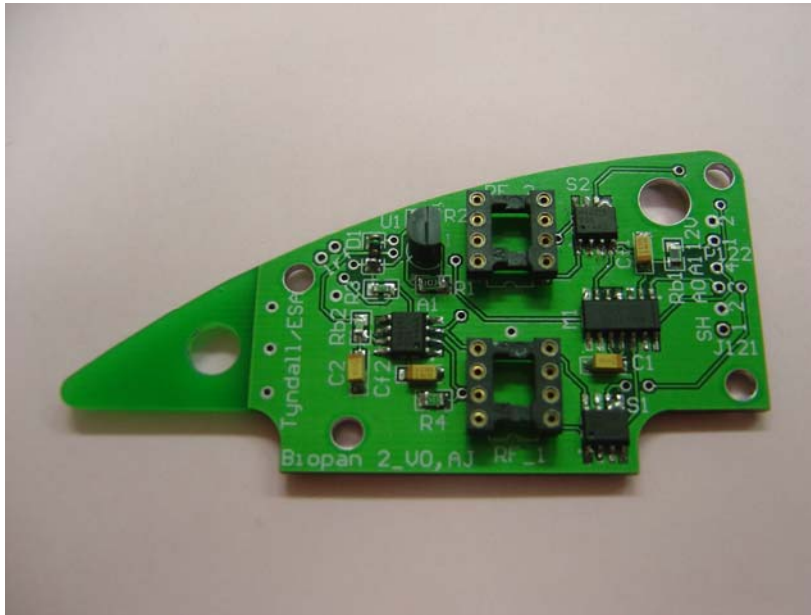


Zero V_{IRR}

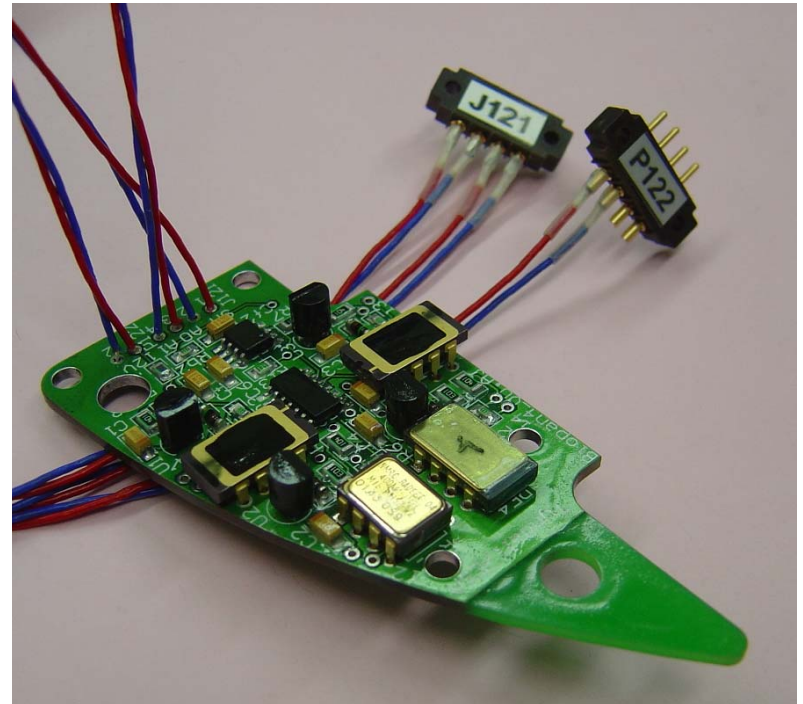


Continuous I_O

BioRADFET boards manufactured:



Zero V_{IRR}



Continuous I_O

Recent success story:

- RADFET development under ESA sponsorship since late 1980s
- Applications: space (ESA, other agencies), particle physics labs.
- New application: QA of radiotherapy treatments
 - OneDose system developed by Sixel Technologies (surface dosimetry)
 - DVS system under development (implantable dosimetry)

